

Application/Control No.	Applicant(s)/Patent under Reexamination
09/890,290	CHENG ET AL.
Examiner	Art Unit
Krishnan S. Menon	1723

SEARCHED					
Class	Subclass	Date	Examiner		
210	321.6 321.61 321.74 - 321.8				
	321.84 to				
	321.89				
	450				
	500.27				
264	41 129				
156	69 187				
	192	,			
	244.12				
95	54				
96	8,10	6/4/2005	KM		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		_		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor search and search update for RCE	6/4/2005	KM		
156/293 word search	1/28/2006	км		